


<b>Search Notes</b> 	<b>Application/Control No.</b> 10598020	<b>Applicant(s)/Patent Under Reexamination</b> DAVIES, CHRISTOPHER MICHAEL
	<b>Examiner</b> WEI ZHAO	<b>Art Unit</b> 2475

SEARCHED			
Class	Subclass	Date	Examiner
370	255	9/8	WZ
709	243, 239	9/8	WZ
455	566	9/8	WZ

SEARCH NOTES		
Search Notes	Date	Examiner
Searched using US-PGPUB, USPAT, DERWENT, IBM, TDB in EAST	9/8	WZ
Did double patenting search and inventorship search for ODP in Palm Resource Center	9/8	WZ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
370	255	9/8	WZ

--	--